

Semiconductor Process Furnaces Multi-Purpose Fast Ramping Bench-Top Space-Saving and Energy Efficient



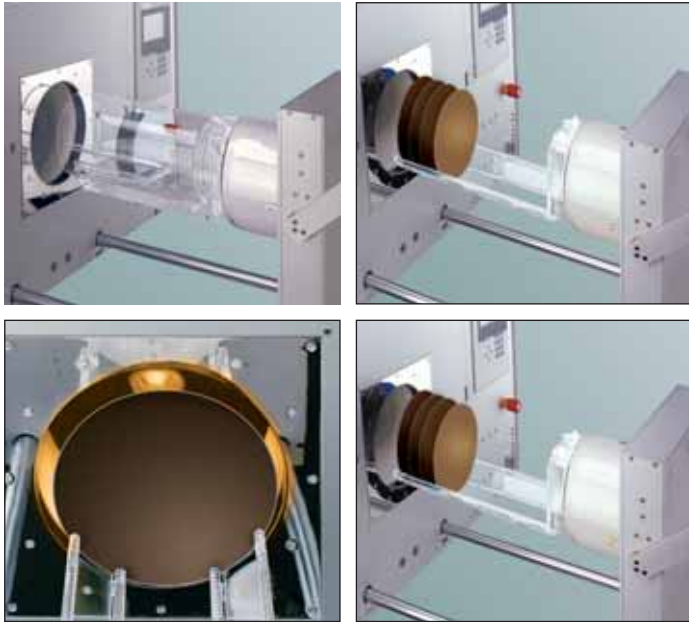
Features

- Temperatures up to 1150°C, $\pm 0.2^\circ\text{C}$
- Fast ramping – Heats at 100°C/minute (max.)
- Fast cool down
- Quartz process chamber
- Up to 300mm diameter wafers or equivalent substrate size
- Vacuum down to 5 x 10⁻⁶ mbar/Torr
- Oxygen < 1 ppm
- Multiple process gases
- Pure hydrogen atmosphere (optional)
- Versatile – multiple processes with one furnace
- 100 steps per program
- Space saving and energy efficient

General Description

The PEO 600 Series furnaces are constructed to be space saving, energy-efficient units that can complete multiple tasks. Each is equipped with a quartz tube sealed by a bell jar mounted on a spring loaded tumbling plate on the door. This design ensures a leak-proof sealing when closed. Ball bearing shafts guide the manual opening and closing of the furnace door, which is locked during operation. An automated open/close door in an available option.

The furnace is heated by 12 Kanthal® resistor wire heaters suitable for temperatures up to 1450°C. Ceramic shafts, wrapped in Kanthal® wire form three individual programmable heating zones around the top, middle and bottom of the chamber. In addition, the oven contains one resistor wire disk heater in the door bell jar and a second one at the far end of the quartz tube, which can also be individually programmed.



LPCVD, diffusion, wet/dry thermal SiO₂, epitaxy, HCl-cleaning

Poly Si, Si₃N₄ and SiO₂, LPCVD like other conflicting processes can be done in the same furnace, by using easy to replace quartz liners/reactor inserts. Evaporator systems for LPCVD, LTO and TEOS are available. For wet thermal SiO₂, the furnace can be equipped with a low-cost bubbler, a DI water evaporator and a hydrogen torch system.

For diffusion with POCl₃ and BBr₃, evaporator systems are available too. Diffusion with solid sources or spin-on coatings are standard features. HCl cleaning can be performed by either HCl gas, TRANS-LC or DCE.

Annealing under N₂, Ar, hydrogen, vacuum

For Pure hydrogen annealing, there is a hydrogen safety system available with automatic nitrogen purge before and after hydrogen flow with gas flow failure alarms. Vacuum annealing can be done down to max. 5×10^{-6} mbar. Inert gas annealing atmospheres can be achieved with a residual oxygen content of 1 ppm.

IR heating – single wafer/substrate RTA

For single wafer/substrate rapid thermal annealing, the furnaces can be equipped with IR quartz lamps achieving approximately 20°C per second. Other ramping rates are available upon request.

Uniformities

To meet customer specific temperature uniformity for a certain application, the furnaces will be temperature profiled with thermocouple wafers or thermocouple substrates. For wafer processes three thermocouple wafers of various diameters with five TCs each are used for profiling. The fine tuning of all five heater zones is performed by setting the offset parameters in the Windows based control software. Each process recipe has an

individually programmable parameter set. Layer thickness can be verified also, which will be in the range of <3% for within wafer non-uniformity, < 5% for wafer to wafer non-uniformity.

Process support

At ATV we strive to meet the individual processing needs of our customers. We welcome customer input in developing new processes and customizing our equipment to each customer's unique requirements.

Low temperature processing

Polyimide curing, SiAu/SiAl.SiMo alloying, wet thermal oxidation on Al for VECSEL, low k dielectrics, post implanting annealing, wafer bump reflow, flux less reflow soldering, LTO, etc.

Program controlled low-temperature processing features programmable heater power with optimized control parameters for each program ensuring excellent temperature control at even low temperatures. By precise temperature control of the front, back, and side heaters, perfect temperature uniformity over the entire batch is achieved, even during ramp up/down providing uniform thermal treatment.

Processing under Nitrogen enriched (~1.5%) by low amounts of Formic Acid (HCOOH) provides shiny round solder balls and perfect solder joints by efficient Oxide removal prior to and during reflow.

Thick film paste – LTCC processing

Various quartz cassettes/carriers are available for horizontal substrate processing of any size. Gas preheating and gas flow in between the substrate ensures optimized process conditions for resistor paste firing. For copper paste firing, low oxygen atmospheres are achievable. For constrained LTCC sintering, a furnace with programmable hydraulic press is available.



Technical Data



	PEO-601	PEO-603	PEO-604	PEO-612
Inner Quarz-tube Ø	112 mm (4-1/2")	230 mm (9")	230 mm (9")	336 mm (13-1/4")
Maximum Capacity <ul style="list-style-type: none"> • Wafer • Ceramic Substrates • Flate Zone 	40 x 100 mm dia., 4.76 mm pitch 40 pieces 2" x 2" 10 pieces 4" x 4" ~ 15 wafers 100 mm dia.	60 x 200 mm dia., 4.76 mm pitch 400 pieces 2" x 2" 120 pieces 4" x 4" 50 wafers 200 mm dia.	60 x 200 mm dia., 4.76 mm pitch 400 pieces 2" x 2" 120 pieces 4" x 4" 50 wafers 200 mm dia.	30 x 300 mm dia., 10 mm pitch, 60 x 200 mm dia., 4.76 mm pitch accordingly 25 wafers 300 mm or 50 wafers 200 mm dia.
Standard Product temperature	1000° C Continuously	1000° C Continuously	1000° C Continuously	1000° C Continuously
Maximum Product temperature	1100° C Continuously	1100° C Continuously	1100° C Continuously Higher upon request	1100° C Continuously Higher upon request
Heating	6 heaters Kanthal® resistor wire wrapped around ceramic shafts, each 1kW 2 zones, easily to replace	12 heaters Kanthal® resistor wire wrapped around ceramic shafts, each 1.6 kW 3 zones, easily to replace plus one each disk heater in the door bell jar and at the far end of the tube	12 heaters Kanthal® resistor wire wrapped around ceramic shafts, each 1.6 kW easily to replace plus one each disk heater in the door bell jar and at the end of the tube, 5 zones	24 heaters Kanthal® resistor wire wrapped around ceramic shafts, each 1.6 kW easily to replace plus one each disk heater in the door bell jar and at the end of the tube, 5 zones
Processing of inflammable and poisoned gases	no	no	yes, process tube, thermal insulation and heaters are inside a sealed metal box with N2 purge capability, cooling air in/out is controlled by program and interlock controlled shutters	yes, process tube, thermal insulation and heaters are inside a sealed metal box with N2 purge capability, cooling air in/out is controlled by program and interlock controlled shutters
Low temperature processing	feasible	feasible	perfectly by reduced heater power with 24 heaters in series	perfectly by reduced heater power with 24 heaters in series
Faster ramp up/down	no/no	no/yes by rapid N2 cooling capability	yes, by double heater power and rapid N2 cooling capability	no/yes, by rapid N2 cooling capability
Vacuum capability	5 x 10 ⁻² mbar Max	5 x 10 ⁻⁶ mbar Max	5 x 10 ⁻⁶ mbar Max	5 x 10 ⁻⁶ mbar Max
Power supply <ul style="list-style-type: none"> • Europa • Country Specific 	3 phases, 230/400 VAC, 5 wires neutral ground, 16 A, max. 7 kW Please Specify	3 phases, 230/400 VAC, 5 wires neutral ground, 32 A, max. 21 kW Please Specify	3 phases, 400 VAC, 5 wires neutral ground, 32/63 A, 21/42 kW Please Specify	3 phases, 400 VAC, 5 wires neutral ground, 32/63 A, 21/42 kW Please Specify
Power consumption	< 20 %	< 20 %	< 20 %	< 20 %
Dimensions <ul style="list-style-type: none"> • Millimeters • Inches 	710 x 650 x 460 28" W x 25" H x 18" D	1000 x 710 x 800 39" W x 28" H x 31" D	800 x 1900 x 1400 mm 31" W x 75" H x 55" D	1000 x 1900 x 1400 mm 39" W x 75" H x 55" D
Weight	~ 45 kg (100 lbs)	~ 270 kg (600 lbs)	~ 475 kg (1050 lbs)	~ 540 kg (1200 lbs)



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